

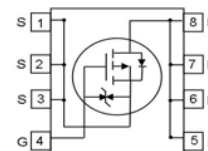
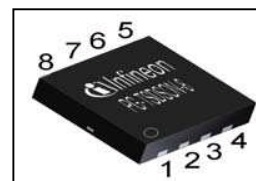
OptiMOS™ P3 Power-Transistor
Features

- single P-Channel in S308
- Qualified according JEDEC¹⁾ for target applications
- 150 °C operating temperature
- $V_{GS}=25$ V, specially suited for notebook applications
- Pb-free; RoHS compliant
- ESD protected
- applications: battery management, load switching
- Halogen-free according to IEC61249-2-21


Product Summary

| | | |
|------------------|-------|----|
| V_{DS} | -30 | V |
| $R_{DS(on),max}$ | 18 | mΩ |
| I_D | -39.6 | A |

PG-TSDSON-8



| Type | Package | Marking | Lead free | Halogen free | Packing |
|-----------------|-------------|---------|-----------|--------------|---------|
| BSZ180P03NS3E G | PG-TSDSON-8 | 180P3NE | Yes | Yes | non-dry |

Maximum ratings, at $T_j=25$ °C, unless otherwise specified

| Parameter | Symbol | Conditions | Value | Unit |
|-------------------------------------|----------------|----------------------------|------------------|------|
| Continuous drain current | I_D | $T_C=25$ °C | 39.6 | A |
| | | $T_C=70$ °C | 32.0 | |
| | | $T_A=25$ °C ²⁾ | -9.0 | |
| Pulsed drain current | $I_{D,pulse}$ | $T_C=25$ °C ³⁾ | -158 | |
| Avalanche energy, single pulse | E_{AS} | $I_D=-20$ A, $R_{GS}=25$ Ω | 48 | mJ |
| Gate source voltage | V_{GS} | | ±25 | V |
| Power dissipation | P_{tot} | $T_A=25$ °C | 40 | W |
| | | $T_A=25$ °C ²⁾ | 2.1 | |
| Operating and storage temperature | T_j, T_{stg} | | -55 ... 150 | °C |
| ESD class | | JESD22-A114 HBM | class 2 (> 2 kV) | |
| Soldering temperature | | | 260 | °C |
| IEC climatic category; DIN IEC 68-1 | | | 55/150/56 | |

¹⁾ J-STD20 and JESD22

| Parameter | Symbol | Conditions | Values | | | Unit |
|-----------|--------|------------|--------|------|------|------|
| | | | min. | typ. | max. | |

Thermal characteristics

| | | | | | | |
|--|------------|--|---|---|-----|-----|
| Thermal resistance, junction - case | R_{thJC} | | - | - | 3.1 | K/W |
| Thermal resistance, junction - ambient | R_{thJA} | 6 cm ² cooling area ²⁾ | - | - | 60 | |

Electrical characteristics, at $T_j=25$ °C, unless otherwise specified
Static characteristics

| | | | | | | |
|----------------------------------|---------------|--|------|------|------|------------|
| Drain-source breakdown voltage | $V_{(BR)DSS}$ | $V_{GS}=0$ V, $I_D=-250$ μ A | -30 | - | - | V |
| Gate threshold voltage | $V_{GS(th)}$ | $V_{DS}=V_{GS}$, $I_D=-48$ μ A | -3.1 | -2.5 | -1.9 | |
| Zero gate voltage drain current | I_{DSS} | $V_{DS}=-30$ V, $V_{GS}=0$ V, $T_j=25$ °C | - | - | -1 | μ A |
| | | $V_{DS}=-30$ V, $V_{GS}=0$ V, $T_j=125$ °C | - | - | -100 | |
| Gate-source leakage current | I_{GSS} | $V_{GS}=-25$ V, $V_{DS}=0$ V | - | - | -10 | μ A |
| Drain-source on-state resistance | $R_{DS(on)}$ | $V_{GS}=-6$ V, $I_D=-13$ A | - | 18.4 | 30.0 | m Ω |
| | | $V_{GS}=-10$ V, $I_D=-20$ A | - | 13.5 | 18.0 | |
| Gate resistance | R_G | | - | 3.1 | - | Ω |
| Transconductance | g_{fs} | $ V_{DS} >2 I_D R_{DS(on)max}$, $I_D=-20$ A | 18 | 29 | - | S |

²⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μ m thick) copper area for drain connection. PCB is vertical in still air.

³⁾ See Fig. 3 for more detailed information

| Parameter | Symbol | Conditions | Values | | | Unit |
|-----------|--------|------------|--------|------|------|------|
| | | | min. | typ. | max. | |

Dynamic characteristics

| | | | | | | |
|------------------------------|--------------|--|---|------|------|----|
| Input capacitance | C_{iss} | $V_{GS}=0\text{ V}, V_{DS}=-15\text{ V},$ $f=1\text{ MHz}$ | - | 1480 | 2220 | pF |
| Output capacitance | C_{oss} | | - | 744 | 1116 | |
| Reverse transfer capacitance | C_{rss} | | - | 49 | 73.5 | |
| Turn-on delay time | $t_{d(on)}$ | $V_{DD}=-15\text{ V}, V_{GS}=-$ $10\text{ V}, I_D=-20\text{ A},$ $R_G=6\ \Omega$ | - | 11 | 17 | ns |
| Rise time | t_r | | - | 11 | 16.5 | |
| Turn-off delay time | $t_{d(off)}$ | | - | 20 | 30 | |
| Fall time | t_f | | - | 3 | 5 | |

Gate Charge Characteristics³⁾

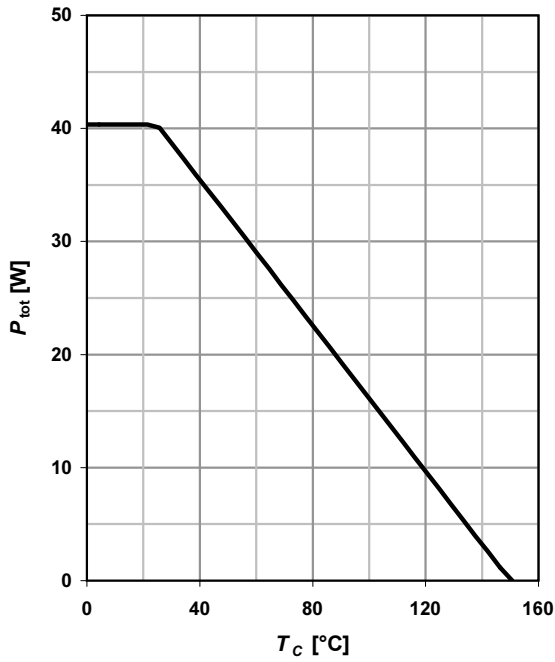
| | | | | | | |
|--------------------------|---------------|--|-----|----|----|----|
| Gate to source charge | Q_{gs} | $V_{DD}=-15\text{ V}, I_D=20\text{ A},$ $V_{GS}=0\text{ to }-10\text{ V}$ | - | 8 | 12 | nC |
| Gate charge at threshold | $Q_{g(th)}$ | | - | 2 | 3 | |
| Gate to drain charge | Q_{gd} | | - | 4 | 5 | |
| Switching charge | Q_{sw} | | - | 9 | 13 | |
| Gate charge total | Q_g | | - | 20 | 30 | |
| Gate plateau voltage | $V_{plateau}$ | - | 5.0 | - | V | |
| Output charge | Q_{oss} | $V_{DD}=-15\text{ V}, V_{GS}=0\text{ V}$ | - | 17 | 26 | nC |

Reverse Diode

| | | | | | | |
|----------------------------------|---------------|--|---|----|------|----|
| Diode continuous forward current | I_S | $T_C=25\text{ }^\circ\text{C}$ | - | - | 40 | A |
| Diode pulse current | $I_{S,pulse}$ | | - | - | 160 | |
| Diode forward voltage | V_{SD} | $V_{GS}=0\text{ V}, I_F=-20\text{ A},$ $T_j=25\text{ }^\circ\text{C}$ | - | - | -1.1 | V |
| Reverse recovery time | t_{rr} | $V_R=15\text{ V}, I_F= I_S ,$ $di_F/dt=100\text{ A}/\mu\text{s}$ | - | 41 | - | ns |
| Reverse recovery charge | Q_{rr} | | - | 41 | - | nC |

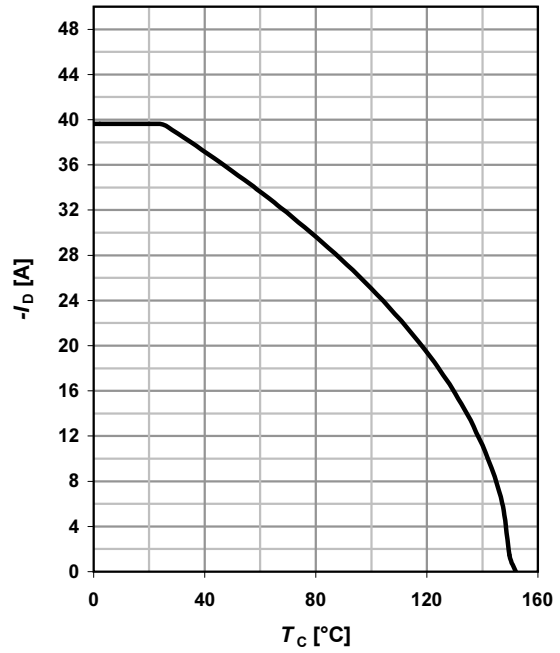
1 Power dissipation

$P_{tot}=f(T_C); t_p \leq 10 \text{ s}$



2 Drain current

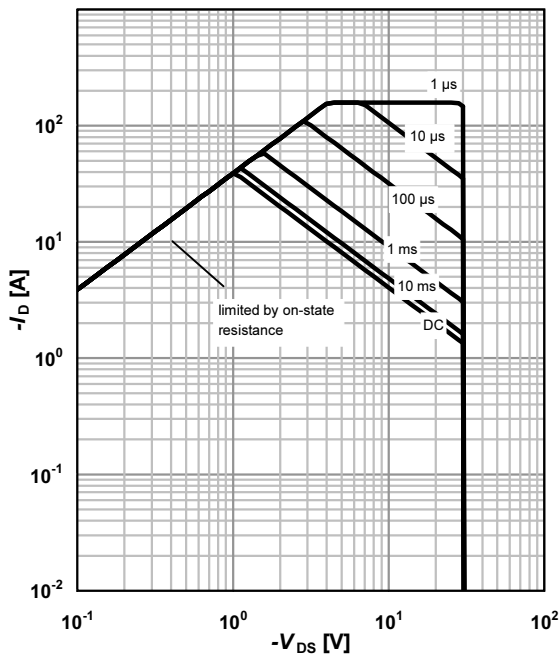
$I_D=f(T_C); |V_{GS}| \geq 10 \text{ V}; t_p \leq 10 \text{ s}$



3 Safe operating area

$I_D=f(V_{DS}); T_C=25 \text{ °C}^1; D=0$

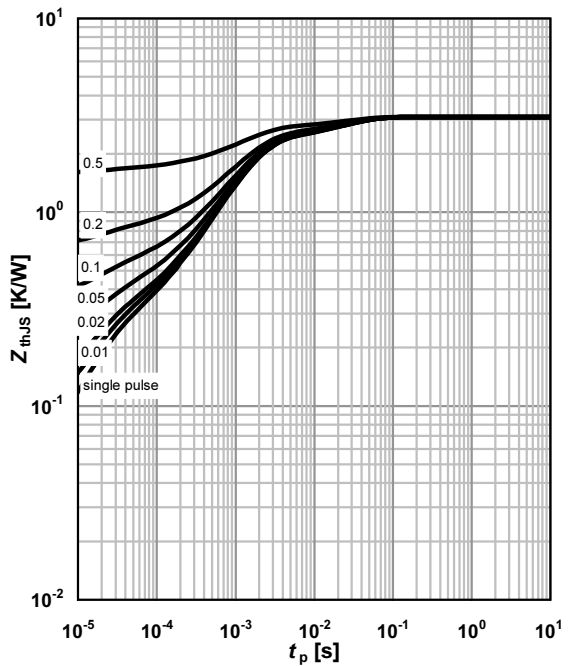
parameter: t_p



4 Max. transient thermal impedance

$Z_{thJS}=f(t_p)$

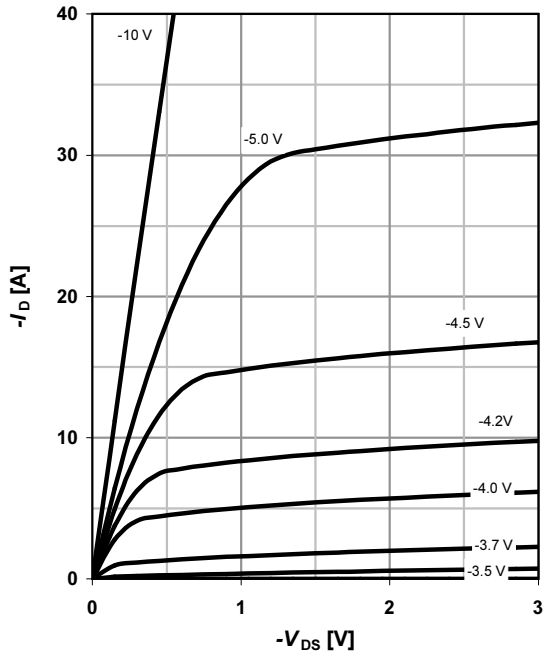
parameter: $D=t_p/T$



5 Typ. output characteristics

$I_D = f(V_{DS}); T_j = 25\text{ }^\circ\text{C}$

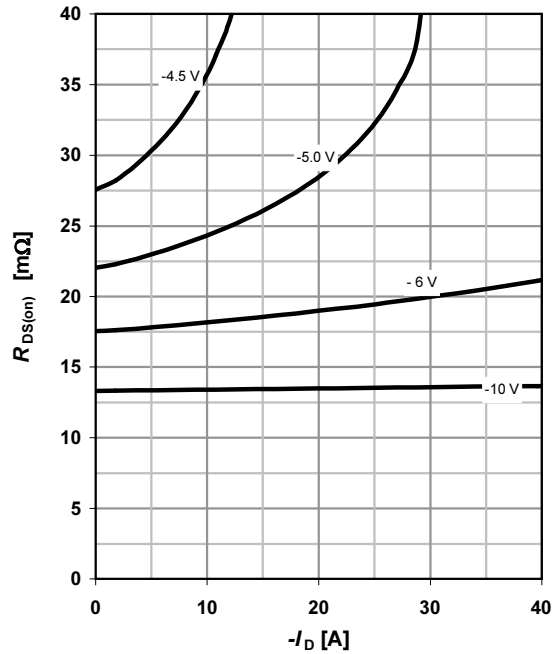
parameter: V_{GS}



6 Typ. drain-source on resistance

$R_{DS(on)} = f(I_D); T_j = 25\text{ }^\circ\text{C}$

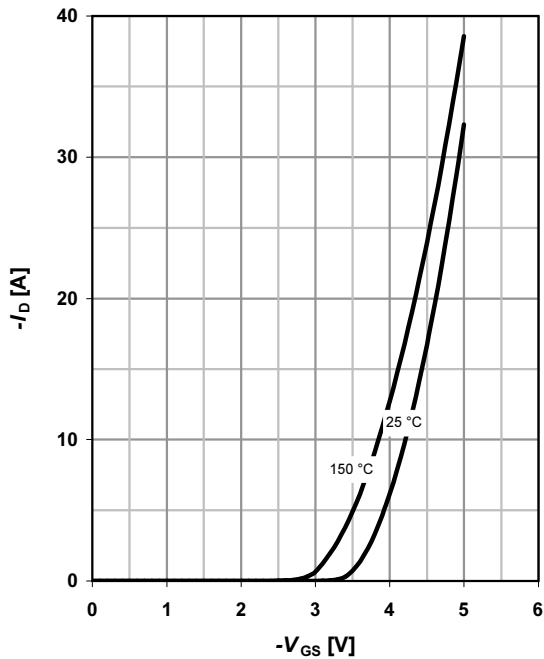
parameter: V_{GS}



7 Typ. transfer characteristics

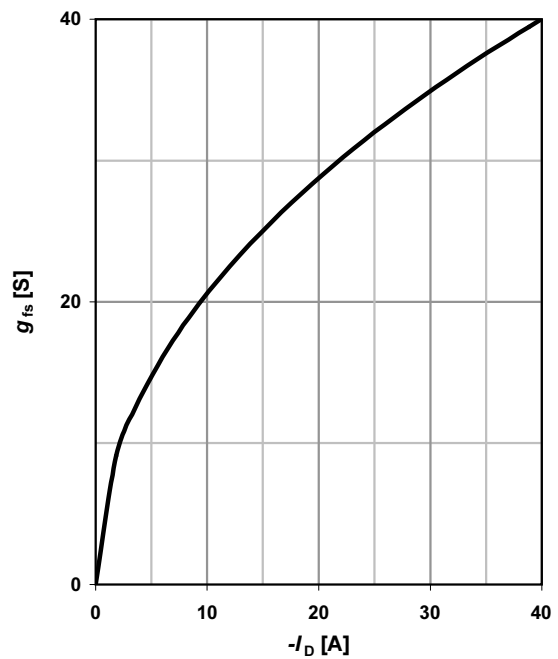
$I_D = f(V_{GS}); |V_{DS}| > 2|I_D|R_{DS(on)max}$

parameter: T_j



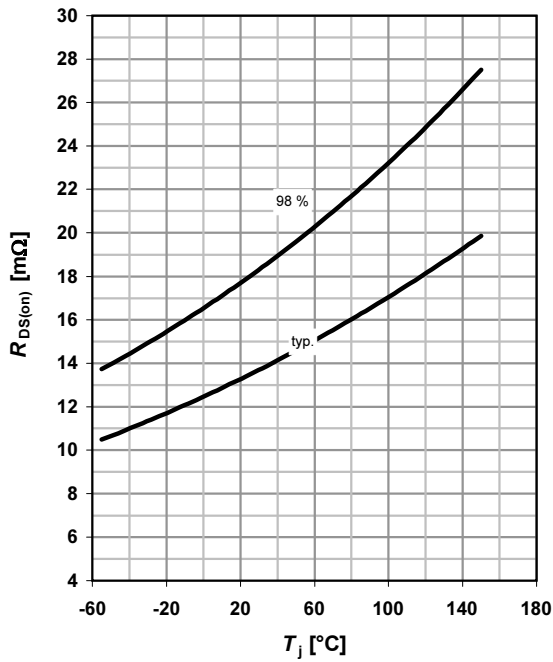
8 Typ. forward transconductance

$g_{fs} = f(I_D); T_j = 25\text{ }^\circ\text{C}$

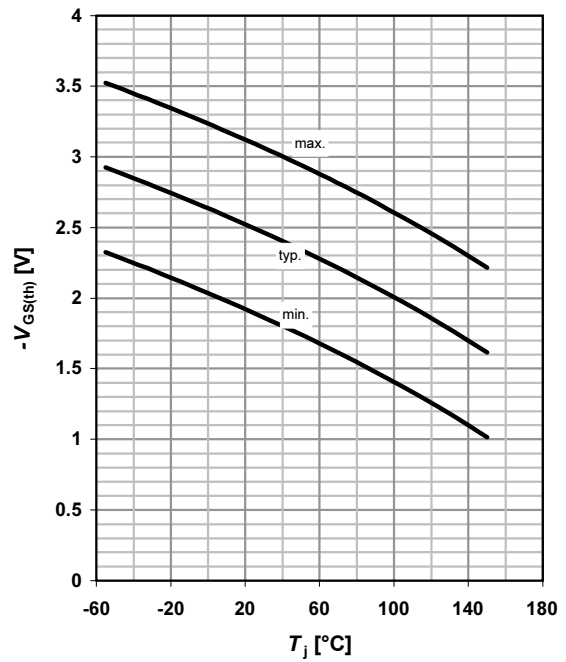


9 Drain-source on-state resistance

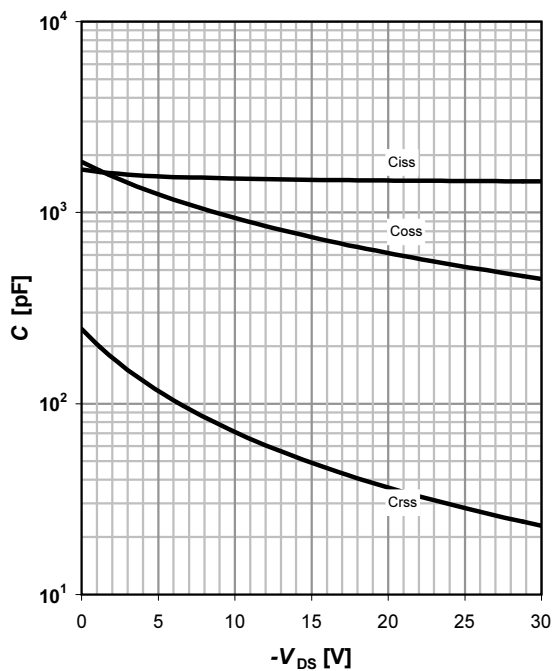
$$R_{DS(on)} = f(T_j); I_D = -20 \text{ A}; V_{GS} = -10 \text{ V}$$


10 Typ. gate threshold voltage

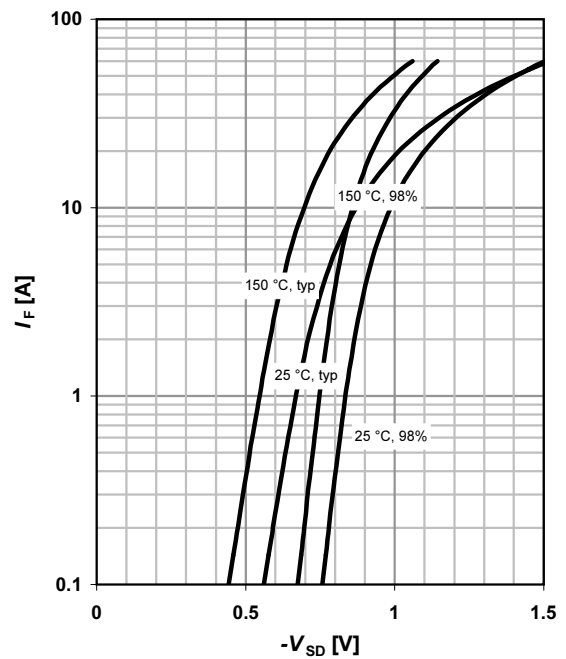
$$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}; I_D = -48 \mu\text{A}$$


11 Typ. capacitances

$$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$$

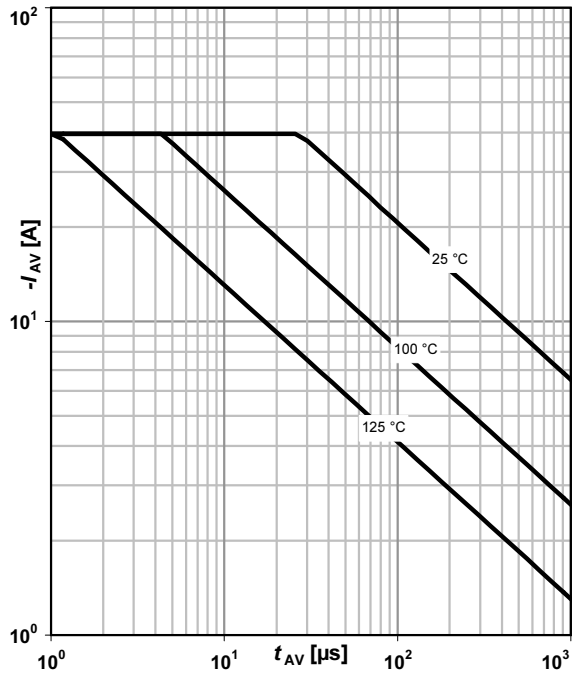

12 Forward characteristics of reverse diode

$$I_F = f(V_{SD})$$

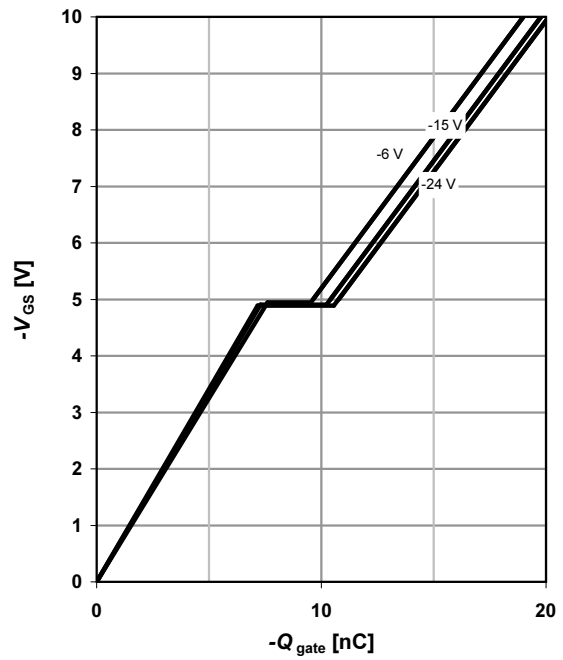
 parameter: T_j


13 Avalanche characteristics

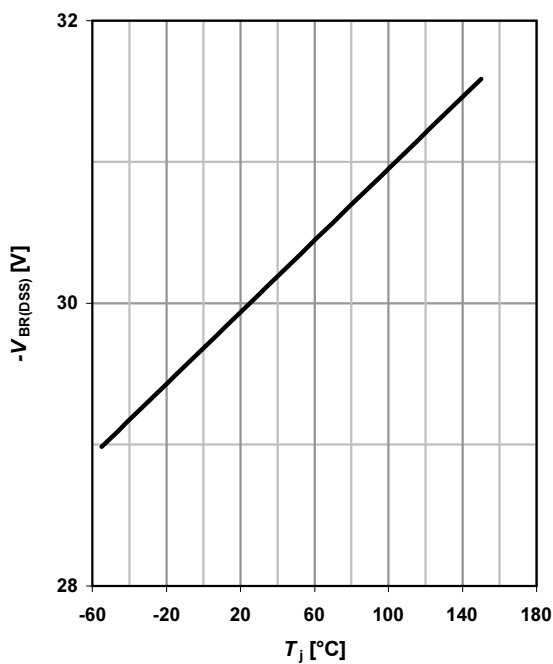
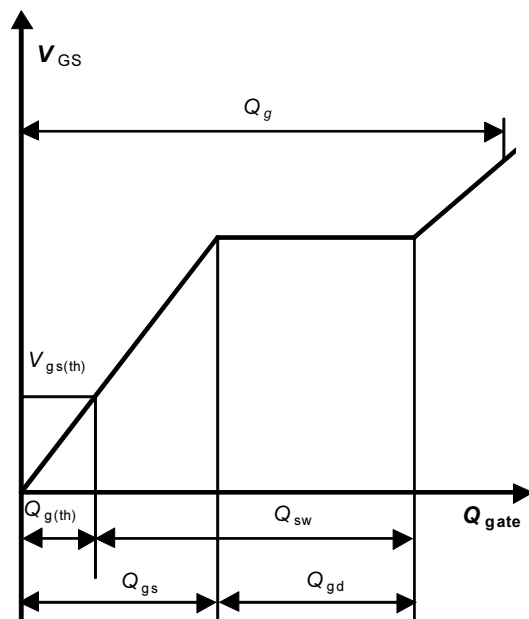
$$I_{AS} = f(t_{AV}); R_{GS} = 25 \Omega$$

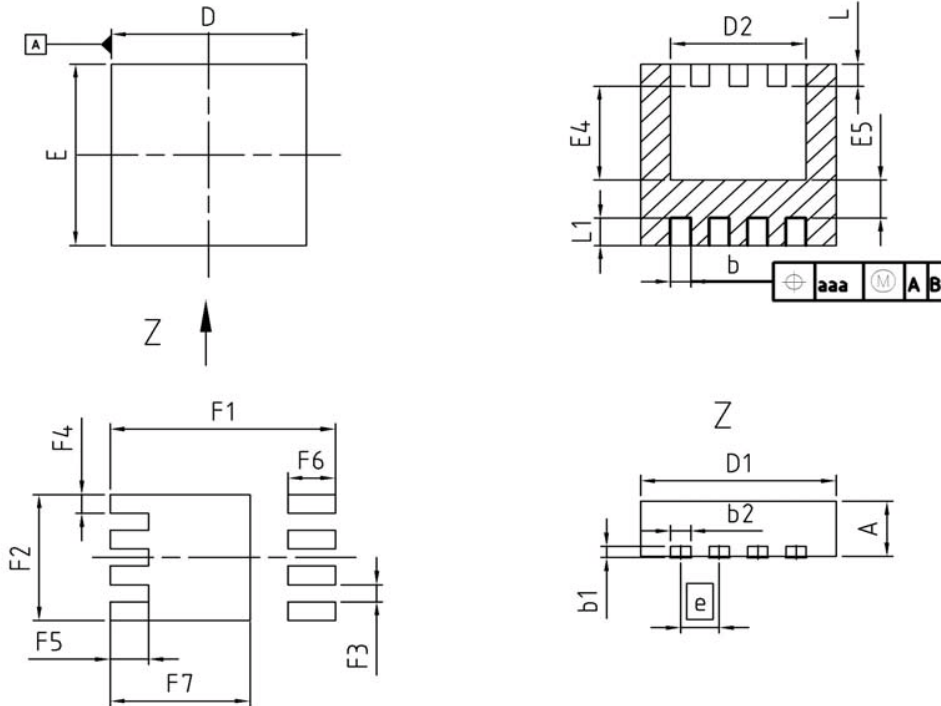
 parameter: $T_{j(\text{start})}$

14 Typ. gate charge

$$V_{GS} = f(Q_{\text{gate}}); I_D = -20 \text{ A pulsed}$$

 parameter: V_{DD}

15 Drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_j); I_D = -250 \mu\text{A}$$


16 Gate charge waveforms


Package Outline
PG-TSDSON-8


| DIM | MILLIMETERS | | INCHES | |
|------|-------------|------|--------|-------|
| | MIN | MAX | MIN | MAX |
| A | 0.90 | 1.10 | 0.035 | 0.043 |
| b | 0.24 | 0.44 | 0.009 | 0.017 |
| b1 | 0.10 | 0.30 | 0.004 | 0.012 |
| b2 | 0.20 | 0.44 | 0.008 | 0.017 |
| D=D1 | 3.20 | 3.40 | 0.126 | 0.134 |
| D2 | 2.15 | 2.45 | 0.085 | 0.096 |
| E | 3.20 | 3.40 | 0.126 | 0.134 |
| E4 | 1.60 | 1.81 | 0.063 | 0.071 |
| E5 | 0.59 | 0.86 | 0.023 | 0.034 |
| e | 0.65 | | 0.026 | |
| N | 8 | | 8 | |
| L | 0.30 | 0.56 | 0.012 | 0.022 |
| L1 | 0.33 | 0.60 | 0.013 | 0.024 |
| aaa | 0.25 | | 0.010 | |
| F1 | 3.80 | | 0.150 | |
| F2 | 2.29 | | 0.090 | |
| F3 | 0.31 | | 0.012 | |
| F4 | 0.34 | | 0.013 | |
| F5 | 0.65 | | 0.026 | |
| F6 | 0.80 | | 0.031 | |
| F7 | 2.36 | | 0.093 | |

| |
|-----------------------------|
| DOCUMENT NO. Z8B00131645 |
| SCALE 0 2.5 5mm |
| EUROPEAN PROJECTION |
| ISSUE DATE 17-09-2008 |
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